

Search Notes

Application/Control No.

10/809,106

Examiner

Teena Mitchell

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

3743

SEARCHED

Class	Subclass	Date	Examiner
128	200.24 201.22 201.23 201.24	1/20/2006	TKM
	201.25 201.21		
	202.11 202.27		
	205.25 206.12		
	206.16 206.17		
	206.21 206.23		
	206.24 206.28		
	207.11 200.27		
	200.28 201.12		
	201.15		
2	171.3 422		
	424 410		
	202		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner